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JC13 Rec'd PCT/PTO 14 APR 2005

Docket No.: 4590-390

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of  
Liviu NICU et al.  
U.S. Patent Application No. *not yet assigned*  
Filed: *herewith*

For: MICROMACHINED GYROSCOPIC SENSOR WITH DETECTION IN THE PLANE OF  
THE MACHINED WAFER

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed with the application and no certification or fee is required.

Please note this is a PCT application in the entry of the National Phase in the U.S. and copies of the references cited were transmitted by WIPO and are believed to be in the file of the above-identified application and readily available to the Examiner. Therefore it is believed that Applicants have met all requirements regarding duty of disclosure under 37 CFR 1.56. A copy of the foreign search report is attached for the Examiner's information. Acknowledgement and consideration of these documents are respectfully requested.

Respectfully submitted,

**LOWE HAUPTMAN & BERNER, LLP**



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Date: April 14, 2005

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**INFORMATION DISCLOSURE  
CITATION IN AN  
APPLICATION**

(PTO-1449)

ATTY. DOCKET NO.  
**4590-390**

**U.S. APPLICATION NO.**  
**Not yet assigned**

**APPLICANT**

FILING DATE herewith	GROUP
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# U.S. PATENT DOCUMENTS

# FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	02/066929A	2002-08-29	WIPO				
	44 28 405 A	1996-02-15	DE				

**OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)**


**EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and consider including it in final rejection of application.